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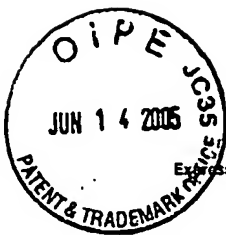
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| Substitute for form 1449A/B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary) | | | | Complete if Known | |
| | | | | Application Number | 10/796,270-Conf. #2382 |
| | | | | Filing Date | March 9, 2004 |
| | | | | First Named Inventor | Jack Z. Peng |
| | | | | Art Unit | 2824 |
| | | | | Examiner Name | H. N. Nguyen |
| Sheet | 1 | of | 2 | Attorney Docket Number | 384848010US |

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| Examiner Signature | <i>HIEN NGUYEN</i> | Date Considered | <i>12/01/05</i> |
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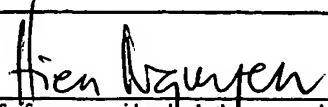
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| | | | | Application Number | 10/796,270 |
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| | | | | Filing Date | |
| | | | | First Named Inventor | Jianguo Wang |
| | | | | Group Art Unit | H. NGUYEN 2824 |
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